

**Search Notes**

Application/Control No.

10/037,168

Examiner

Steven HD Nguyen

Applicant(s)/Patent under  
Reexamination

SHIN ET AL.

Art Unit

2665

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See East search history on the databases	10/15/2005	st